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Application/Control No

10766189

YOSHIUCHI ET AL.

Applicant(s)/Patent Under Reexamination

Examiner

Art Unit

Van Kim T Nguyen

2456

ORIGINAL							INTERNATIONAL CLASSIFICATION										
CLASS SUBCLASS						CLAIMED							NON-CLAIMED				
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Claims renumbered in the same order as presented by applicant								A L	A 1.D. R.1.47						
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Nan Kim T Nguyen/ Examiner.Art Unit 2456		Total Clain	ns Allowed:
(Assistant Examiner)	(Date)	1	8
/Jeffrey Pwu/ Supervisory Patent Examiner.Art Unit 2446	08/27/2009	O.G. Print Claim(s)	O.G. Print Figure
(Primary Examiner)	(Date)	1	1